

Designer's™ Data Sheet
SWITCHMODE™
NPN Bipolar Power Transistor
For Switching Power Supply Applications

The BUL146/BUL146F have an applications specific state-of-the-art die designed for use in fluorescent electric lamp ballasts to 130 Watts and in Switchmode Power supplies for all types of electronic equipment. These high voltage/high speed transistors offer the following:

- Improved Efficiency Due to Low Base Drive Requirements:
 - High and Flat DC Current Gain
 - Fast Switching
 - No Coil Required in Base Circuit for Turn-Off (No Current Tail)
- Full Characterization at 125°C
- Parametric Distributions are Tight and Consistent Lot-to-Lot
- Two Package Choices: Standard TO-220 or Isolated TO-220
- BUL146F, Isolated Case 221D, is UL Recognized to 3500 VRMS: File #E69369

MAXIMUM RATINGS

Rating	Symbol	BUL146	BUL146F	Unit
Collector-Emitter Sustaining Voltage	V _{CEO}	400		V _{dc}
Collector-Emitter Breakdown Voltage	V _{CES}	700		V _{dc}
Emitter-Base Voltage	V _{EBO}	9.0		V _{dc}
Collector Current — Continuous	I _C	6.0		A _{dc}
— Peak(1)	I _{CM}	15		
Base Current — Continuous	I _B	4.0		A _{dc}
— Peak(1)	I _{BM}	8.0		
RMS Isolated Voltage(2) (for 1 sec, R.H. < 30%, T _C = 25°C)	V _{ISOL}	—	4500 3500 1500	V
Test No. 1 Per Fig. 22a Test No. 2 Per Fig. 22b Test No. 3 Per Fig. 22c				
Total Device Dissipation (T _C = 25°C) Derate above 25°C	P _D	100 0.8	40 0.32	Watts W/°C
Operating and Storage Temperature	T _J , T _{stg}	- 65 to 150		°C

THERMAL CHARACTERISTICS

Rating	Symbol	BUL44	BUL44F	Unit
Thermal Resistance — Junction to Case	R _{θJC}	1.25	3.125	°C/W
— Junction to Ambient	R _{θJA}	62.5	62.5	
Maximum Lead Temperature for Soldering Purposes: 1/8" from Case for 5 Seconds	T _L	260		°C

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Collector-Emitter Sustaining Voltage (I _C = 100 mA, L = 25 mH)	V _{CEO(sus)}	400	—	—	V _{dc}
Collector Cutoff Current (V _{CE} = Rated V _{CEO} , I _B = 0)	I _{CEO}	—	—	100	μA _{dc}
Collector Cutoff Current (V _{CE} = Rated V _{CES} , V _{EB} = 0)	I _{CES}	—	—	100	μA _{dc}
(T _C = 125°C)		—	—	500	
(V _{CE} = 500 V, V _{EB} = 0)		—	—	100	
(T _C = 125°C)					
Emitter Cutoff Current (V _{EB} = 9.0 V _{dc} , I _C = 0)	I _{EBO}	—	—	100	μA _{dc}

(1) Pulse Test: Pulse Width = 5.0 ms, Duty Cycle ≤ 10%.

(2) Proper strike and creepage distance must be provided.

(continued)

Designer's Data for "Worst Case" Conditions — The Designer's Data Sheet permits the design of most circuits entirely from the information presented. SOA Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design.

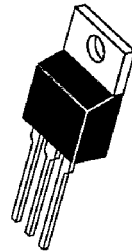
Preferred devices are Motorola recommended choices for future use and best overall value.

REV 1

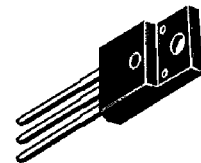
BUL146*
BUL146F*

*Motorola Preferred Device

POWER TRANSISTOR
6.0 AMPERES
700 VOLTS
40 and 100 WATTS



BUL146
CASE 221A-06
TO-220AB



BUL146F
CASE 221D-02
ISOLATED TO-220 TYPE
UL RECOGNIZED

BUL146 BUL146F

ELECTRICAL CHARACTERISTICS — continued ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
ON CHARACTERISTICS					
Base-Emitter Saturation Voltage ($I_C = 1.3 \text{ Adc}, I_B = 0.13 \text{ Adc}$) ($I_C = 3.0 \text{ Adc}, I_B = 0.6 \text{ Adc}$)	$V_{BE(sat)}$	—	0.82 0.93	1.1 1.25	Vdc
Collector-Emitter Saturation Voltage ($I_C = 1.3 \text{ Adc}, I_B = 0.13 \text{ Adc}$) ($T_C = 125^\circ\text{C}$) ($I_C = 3.0 \text{ Adc}, I_B = 0.6 \text{ Adc}$) ($T_C = 125^\circ\text{C}$)	$V_{CE(sat)}$	—	0.22 0.20 0.30 0.30	0.5 0.5 0.7 0.7	Vdc
DC Current Gain ($I_C = 0.5 \text{ Adc}, V_{CE} = 5.0 \text{ Vdc}$) ($T_C = 125^\circ\text{C}$) ($I_C = 1.3 \text{ Adc}, V_{CE} = 1.0 \text{ Vdc}$) ($T_C = 125^\circ\text{C}$) ($I_C = 3.0 \text{ Adc}, V_{CE} = 1.0 \text{ Vdc}$) ($T_C = 125^\circ\text{C}$) ($I_C = 10 \text{ mAdc}, V_{CE} = 5.0 \text{ Vdc}$) ($T_C = 125^\circ\text{C}$)	h_{FE}	14 — 12 12 8.0 7.0 10	— 30 20 20 13 12 20	34 — — — — — —	—

DYNAMIC CHARACTERISTICS

Current Gain Bandwidth ($I_C = 0.5 \text{ Adc}, V_{CE} = 10 \text{ Vdc}, f = 1.0 \text{ MHz}$)	f_T	—	14	—	MHz	
Output Capacitance ($V_{CB} = 10 \text{ Vdc}, I_E = 0, f = 1.0 \text{ MHz}$)	C_{OB}	—	95	150	pF	
Input Capacitance ($V_{EB} = 8.0 \text{ V}$)	C_{IB}	—	1000	1500	pF	
Dynamic Saturation Voltage: Determined 1.0 μs and 3.0 μs respectively after rising I_{B1} reaches 90% of final I_{B1} (see Figure 18)	($I_C = 1.3 \text{ Adc}$ $I_{B1} = 300 \text{ mAdc}$ $V_{CC} = 300 \text{ V}$)	1.0 μs	($T_C = 125^\circ\text{C}$)	— 2.5 6.5	— — —	V
		3.0 μs	($T_C = 125^\circ\text{C}$)	— 0.6 2.5	— — —	
	($I_C = 3.0 \text{ Adc}$ $I_{B1} = 0.6 \text{ Adc}$ $V_{CC} = 300 \text{ V}$)	1.0 μs	($T_C = 125^\circ\text{C}$)	— 3.0 7.0	— — —	
		3.0 μs	($T_C = 125^\circ\text{C}$)	— 0.75 1.4	— — —	

SWITCHING CHARACTERISTICS: Resistive Load (D.C. $\leq 10\%$, Pulse Width = 20 μs)

Turn-On Time	($I_C = 1.3 \text{ Adc}, I_{B1} = 0.13 \text{ Adc}$ $I_{B2} = 0.65 \text{ Adc}, V_{CC} = 300 \text{ V}$) ($T_C = 125^\circ\text{C}$)	t_{on}	— —	100 90	200 —	ns
Turn-Off Time		($T_C = 125^\circ\text{C}$)	t_{off}	— —	1.35 1.90	2.5 —
Turn-On Time	($I_C = 3.0 \text{ Adc}, I_{B1} = 0.6 \text{ Adc}$ $I_{B2} = 1.5 \text{ Adc}, V_{CC} = 300 \text{ V}$) ($T_C = 125^\circ\text{C}$)	t_{on}	— —	90 100	150 —	ns
Turn-Off Time		($T_C = 125^\circ\text{C}$)	t_{off}	— —	1.7 2.1	2.5 —

SWITCHING CHARACTERISTICS: Inductive Load ($V_{clamp} = 300 \text{ V}, V_{CC} = 15 \text{ V}, L = 200 \mu\text{H}$)

Fall Time	($I_C = 1.3 \text{ Adc}, I_{B1} = 0.13 \text{ Adc}$ $I_{B2} = 0.65 \text{ Adc}$) ($T_C = 125^\circ\text{C}$)	t_{fi}	— —	115 120	200 —	ns	
Storage Time		($T_C = 125^\circ\text{C}$)	t_{si}	— —	1.35 1.75	2.5 —	μs
Crossover Time		($T_C = 125^\circ\text{C}$)	t_c	— —	200 210	350 —	ns
Fall Time	($I_C = 3.0 \text{ Adc}, I_{B1} = 0.6 \text{ Adc}$ $I_{B2} = 1.5 \text{ Adc}$) ($T_C = 125^\circ\text{C}$)	t_{fi}	— —	85 100	150 —	ns	
Storage Time		($T_C = 125^\circ\text{C}$)	t_{si}	— —	1.75 2.25	2.5 —	μs
Crossover Time		($T_C = 125^\circ\text{C}$)	t_c	— —	175 200	300 —	ns
Fall Time	($I_C = 3.0 \text{ Adc}, I_{B1} = 0.6 \text{ Adc}$ $I_{B2} = 0.6 \text{ Adc}$) ($T_C = 125^\circ\text{C}$)	t_{fi}	80 —	— 210	180 —	ns	
Storage Time		($T_C = 125^\circ\text{C}$)	t_{si}	2.6 —	— 4.5	3.8 —	μs
Crossover Time		($T_C = 125^\circ\text{C}$)	t_c	— —	230 400	350 —	ns

TYPICAL STATIC CHARACTERISTICS

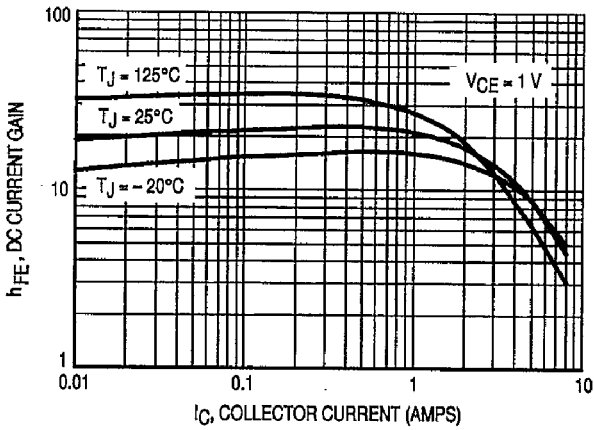


Figure 1. DC Current Gain @ 1 Volt

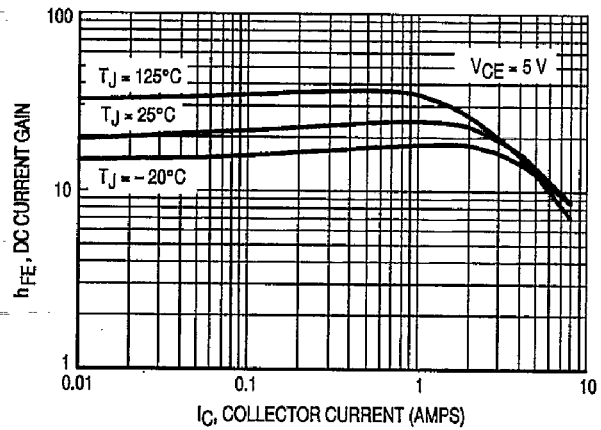


Figure 2. DC Current Gain @ 5 Volts

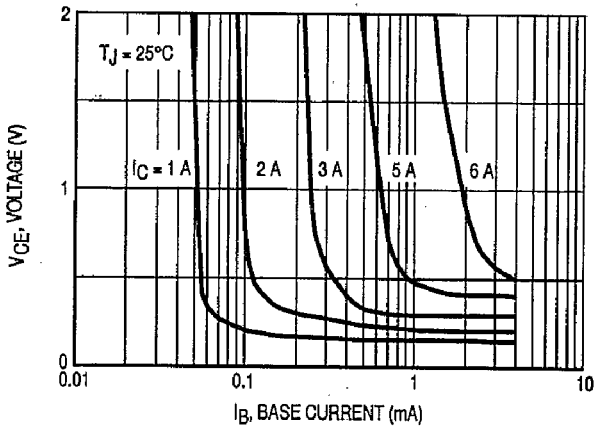


Figure 3. Collector Saturation Region

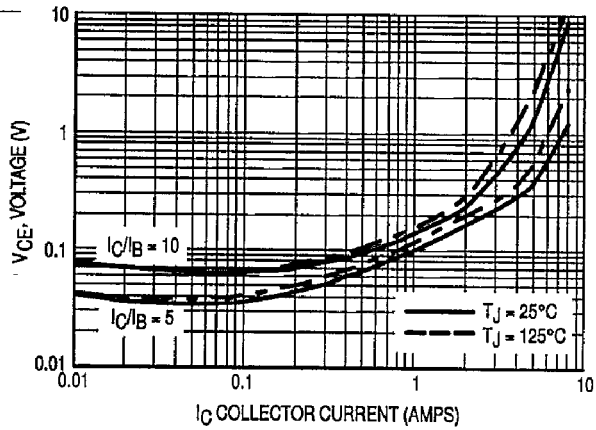


Figure 4. Collector-Emitter Saturation Voltage

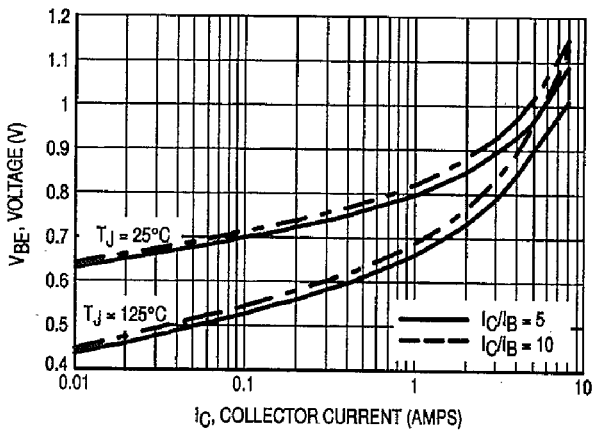


Figure 5. Base-Emitter Saturation Region

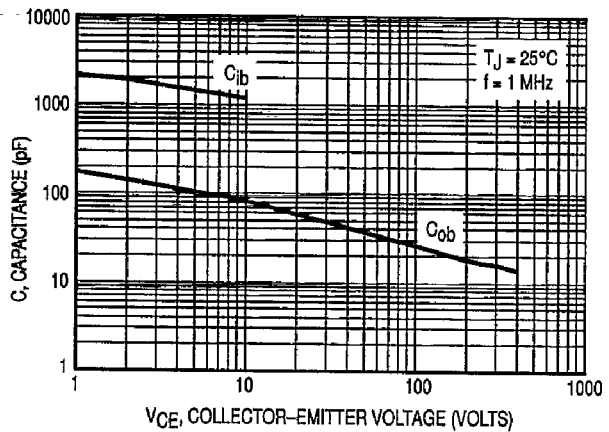


Figure 6. Capacitance

TYPICAL SWITCHING CHARACTERISTICS
($I_B = I_C/2$ for all switching)

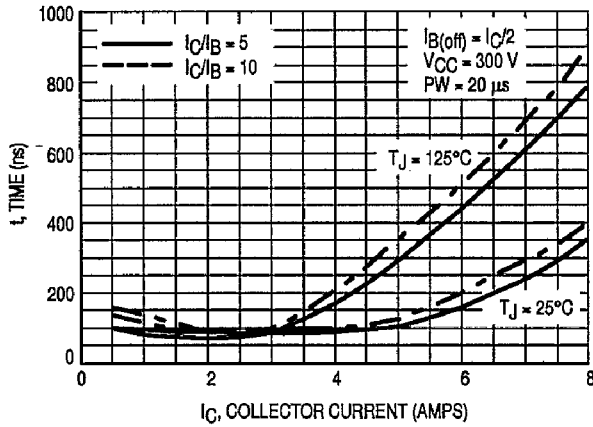


Figure 7. Resistive Switching, t_{on}

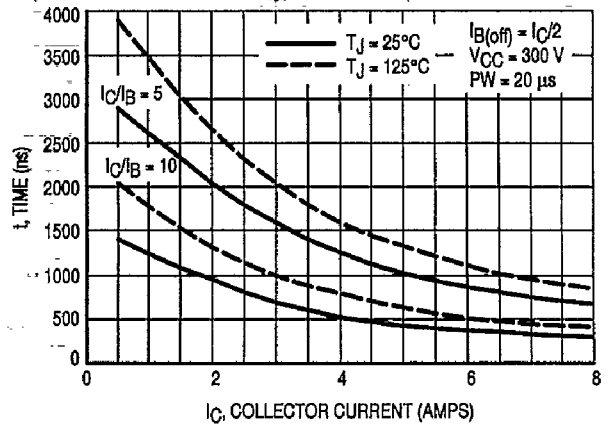


Figure 8. Resistive Switching, t_{off}

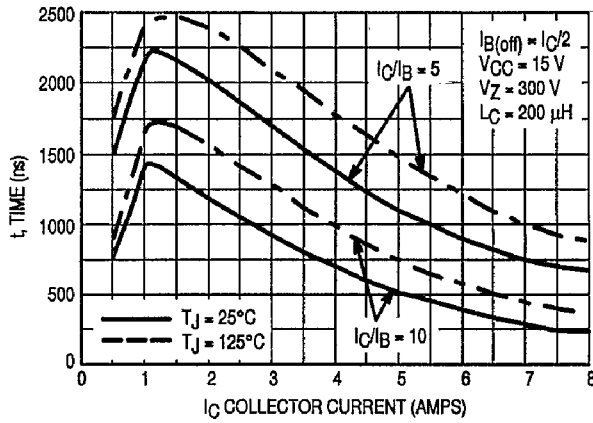


Figure 9. Inductive Storage Time, t_{sl}

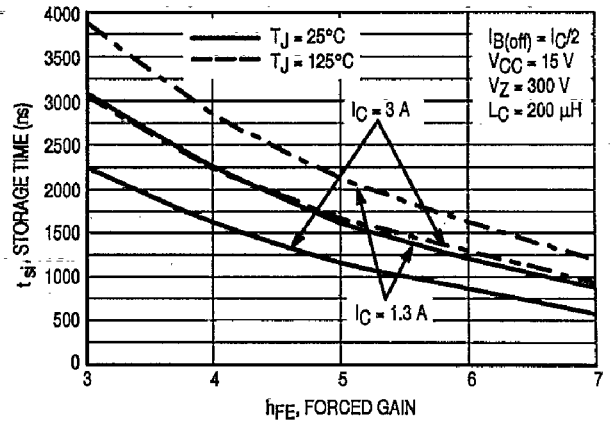


Figure 10. Inductive Storage Time, $t_{sl}(h_{FE})$

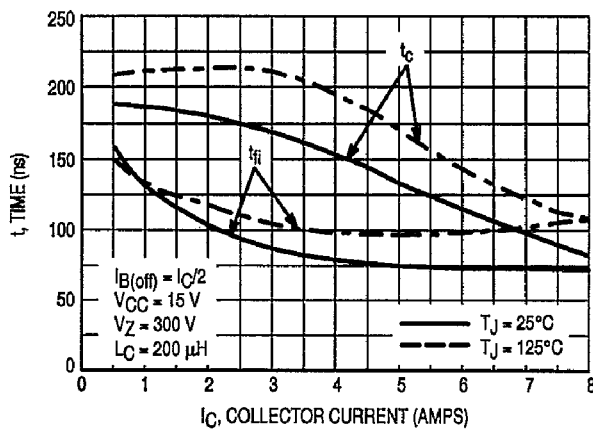


Figure 11. Inductive Switching, t_c and t_{fi}
 $I_C/I_B = 5$

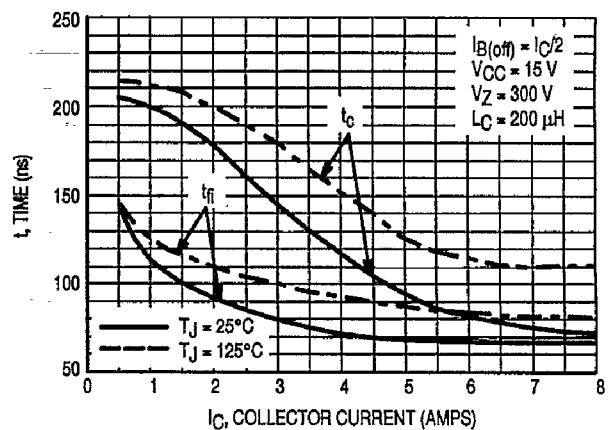


Figure 12. Inductive Switching, t_c and t_{fi}
 $I_C/I_B = 10$

TYPICAL SWITCHING CHARACTERISTICS
($I_B = I_C/2$ for all switching)

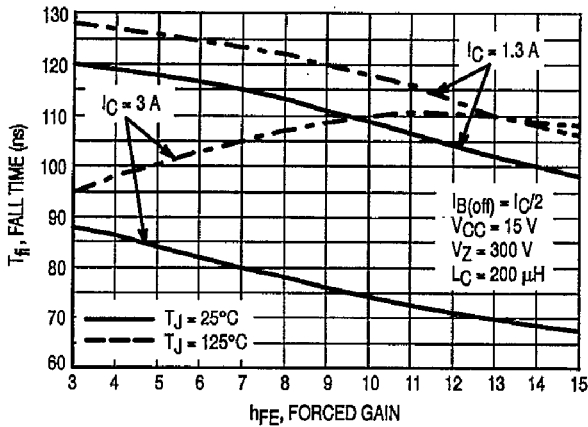


Figure 13. Inductive Fall Time

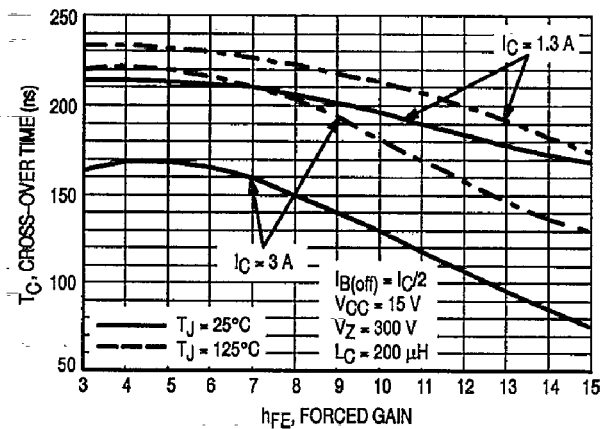


Figure 14. Inductive Cross-Over Time

GUARANTEED SAFE OPERATING AREA INFORMATION

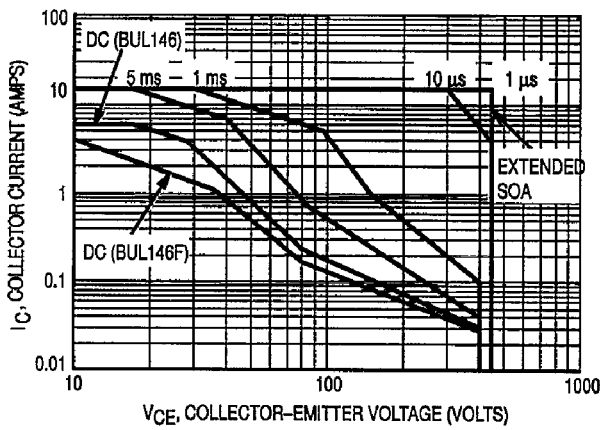


Figure 15. Forward Bias Safe Operating Area

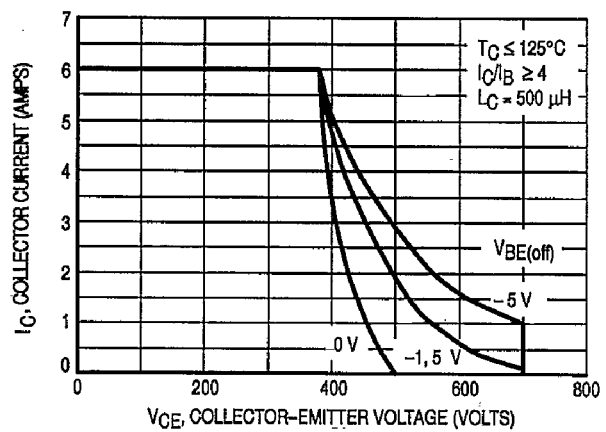


Figure 16. Reverse Bias Switching Safe Operating Area

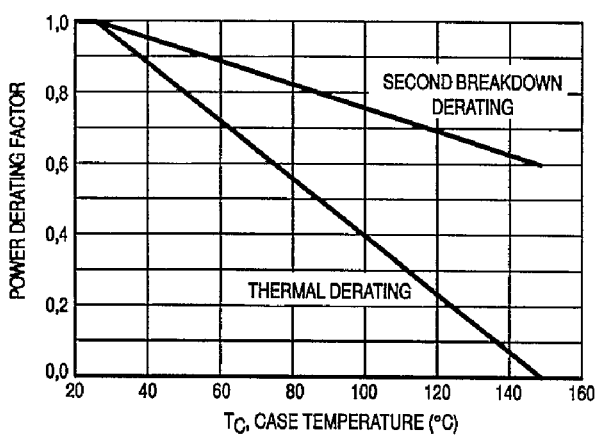


Figure 17. Forward Bias Power Derating

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate. The data of Figure 15 is based on $T_C = 25^\circ\text{C}$; $T_{J(pk)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when $T_C > 25^\circ\text{C}$. Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown in Figure 15 may be found at any case temperature by using the appropriate curve on Figure 17. $T_{J(pk)}$ may be calculated from the data in Figure 20 and 21. At any case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown. For inductive loads, high voltage and current must be sustained simultaneously during turn-off with the base-to-emitter junction reverse-biased. The safe level is specified as a reverse-biased safe operating area (Figure 16). This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode.

BUL146 BUL146F

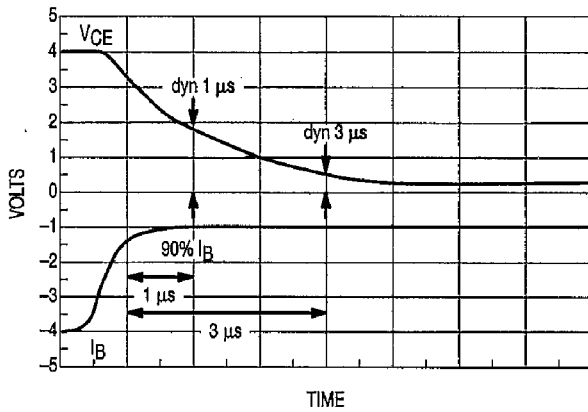


Figure 18. Dynamic Saturation Voltage Measurements

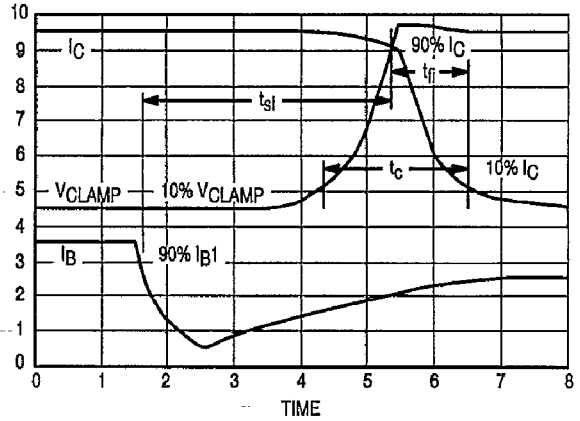


Figure 19. Inductive Switching Measurements

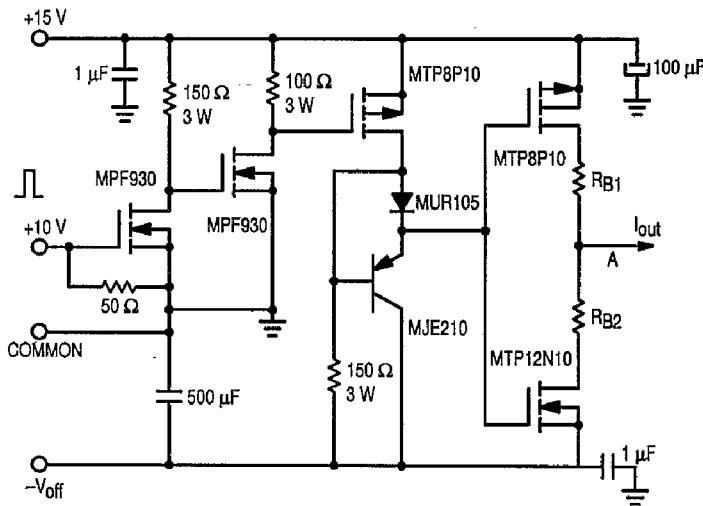
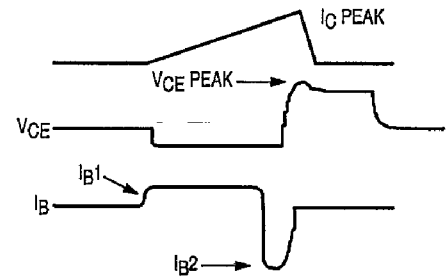


Table 1. Inductive Load Switching Drive Circuit



$V(BR)_{CEO}(sus)$	INDUCTIVE SWITCHING	RBSOA
$L = 10 \text{ mH}$	$L = 200 \mu\text{H}$	$L = 500 \mu\text{H}$
$RB2 = \infty$	$RB2 = 0$	$RB2 = 0$
$V_{CC} = 20 \text{ VOLTS}$	$V_{CC} = 15 \text{ VOLTS}$	$V_{CC} = 15 \text{ VOLTS}$
$I_C(pk) = 100 \text{ mA}$	$RB1$ SELECTED FOR DESIRED I_{B1}	$RB1$ SELECTED FOR DESIRED I_{B1}

TYPICAL THERMAL RESPONSE

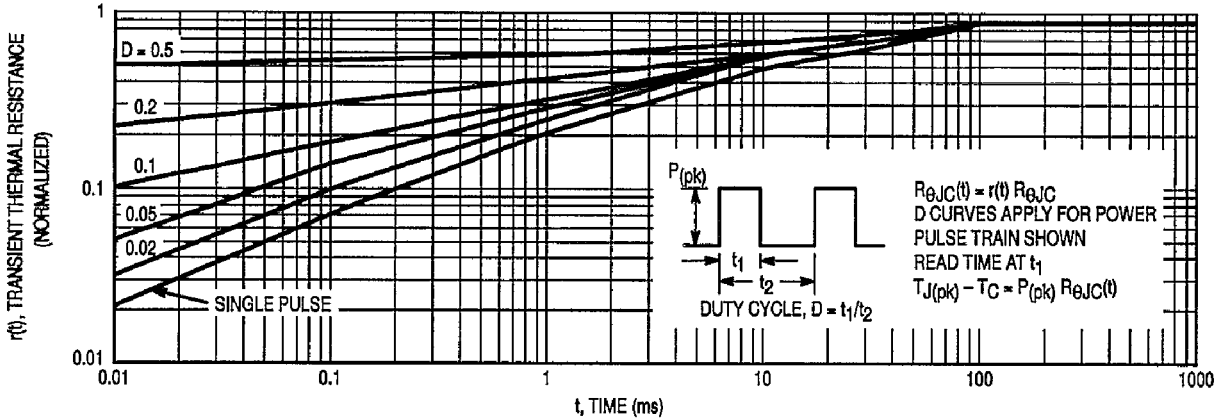


Figure 20. Typical Thermal Response ($Z_{\theta JC}(t)$) for BUL146

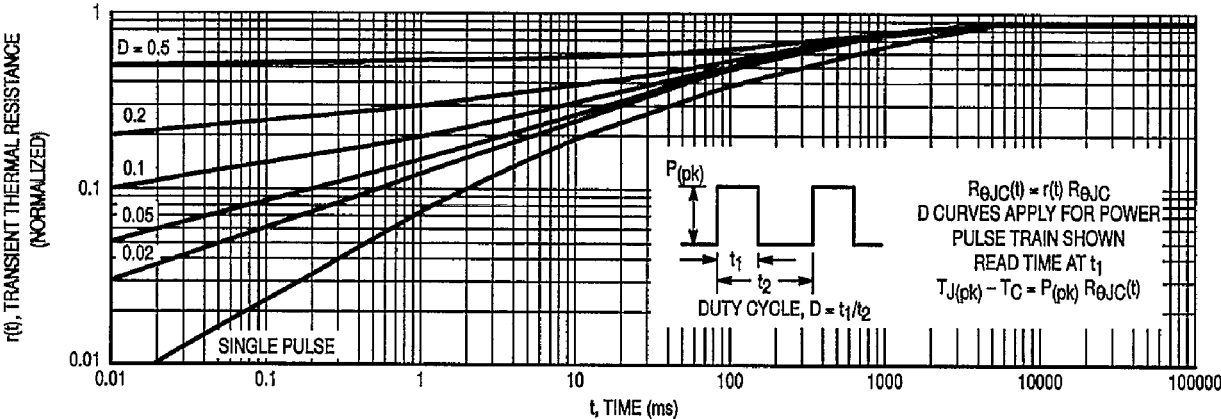
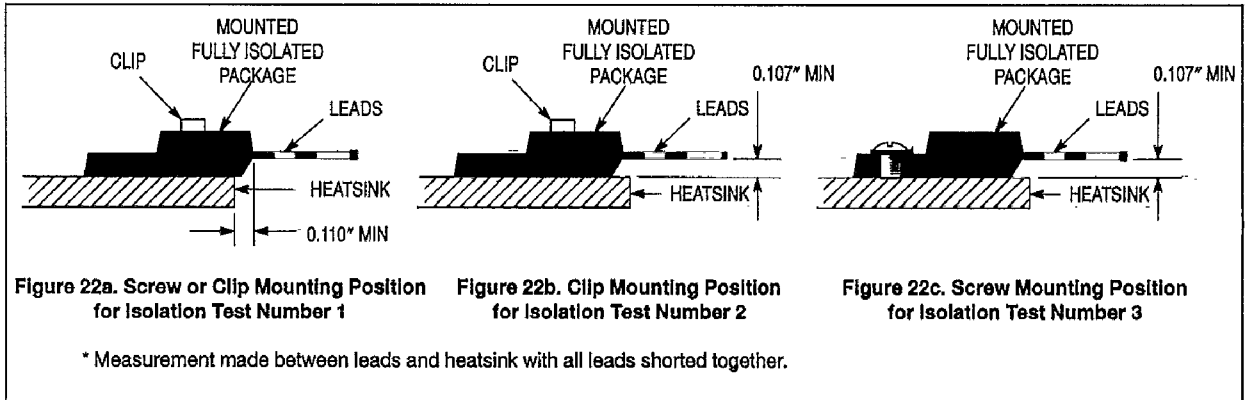
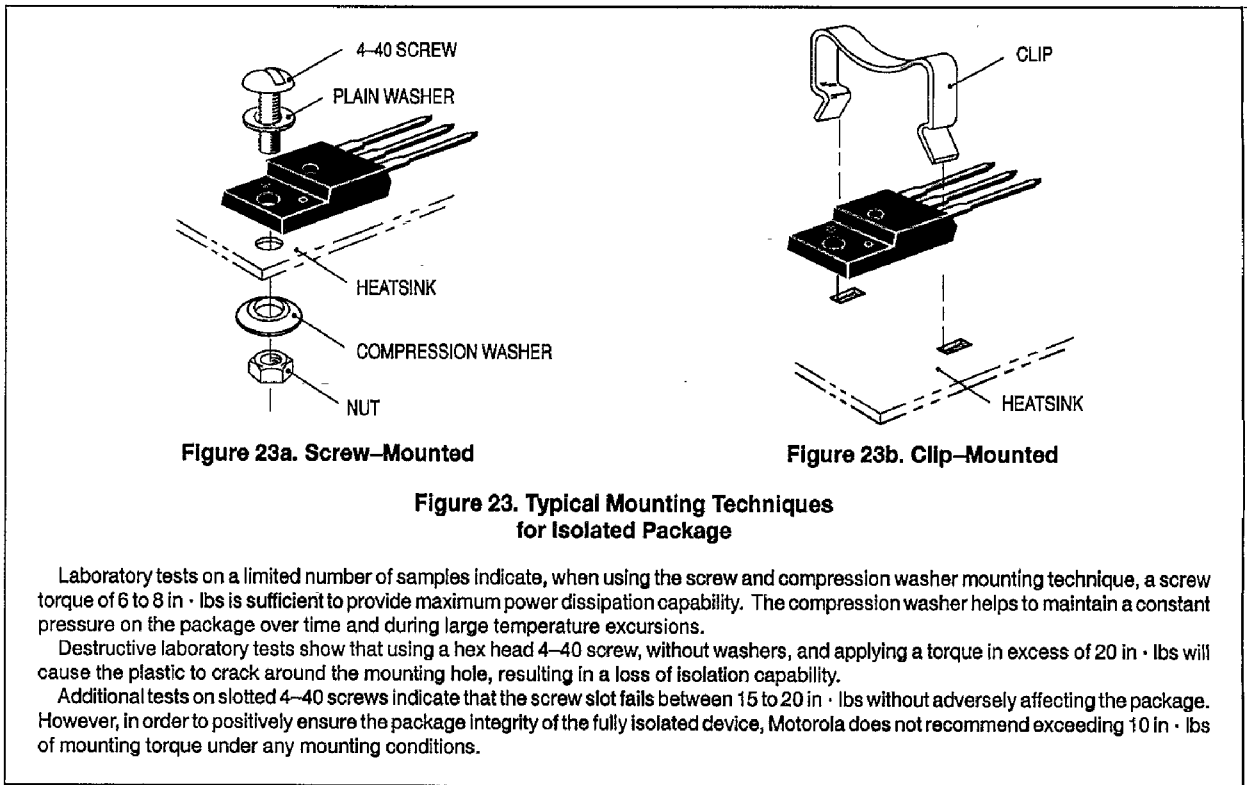


Figure 21. Typical Thermal Response ($Z_{\theta JC}(t)$) for BUL146F

TEST CONDITIONS FOR ISOLATION TESTS*



MOUNTING INFORMATION**



**For more information about mounting power semiconductors see Application Note AN1040.